

Primary and secondary scintillation of Ar/N₂ and Ar/CF₄ mixtures under X-ray irradiation

Raúl Señarís Buso, G. Barco, S. Leardini, P. Amedo, F. Brunbauer, D. González-Díaz, E. Oliveri

GDD

Gas Detectors Development Group

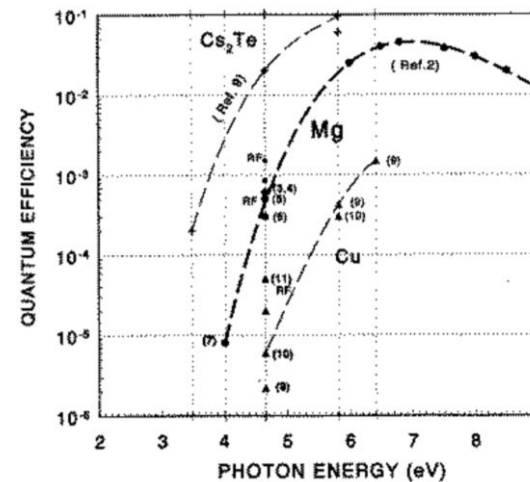
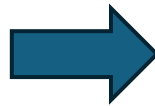
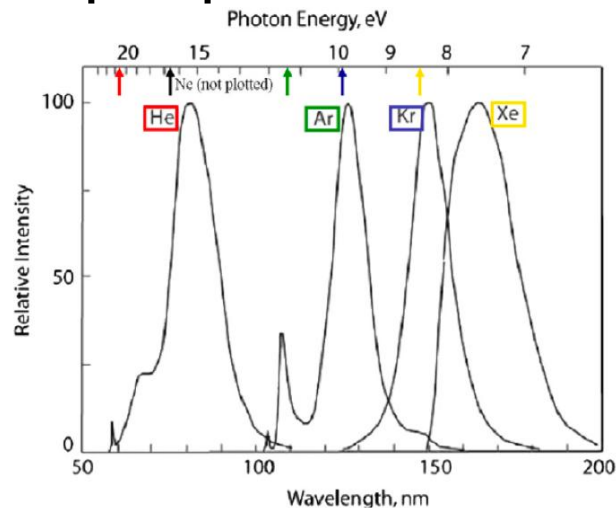


IGFAE

Instituto Galego de Física de Altas Enerxías

Optical readout

- Alternative to traditional charge readout
- Advantages:
 - Cheaper
 - Easier to get highly pixelated readouts
 - Simpler readout
- Principal problem: VUV emission and photon feedback



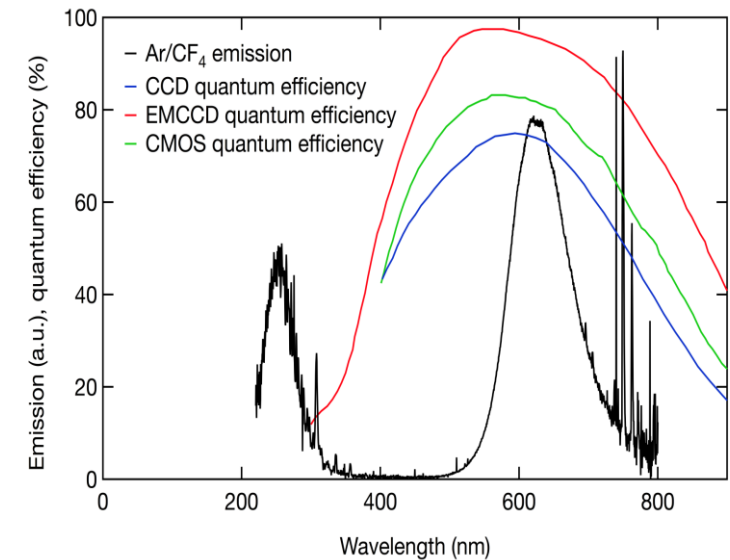
CF₄ and motivation for this work

- CF₄:
 - Good VUV quencher
 - Scintillation spectra in the visible region (good Q.E.)
 - Good electron cooler
- Problems:
 - High GWP
 - Becoming more expensive



Need to find alternative gases (eco-gases)

└─ Nitrogen



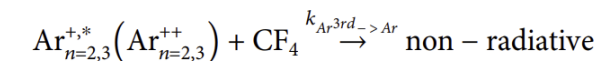
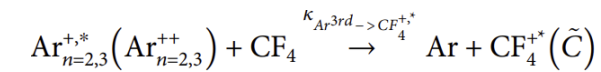
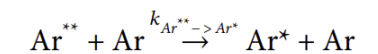
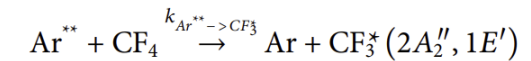
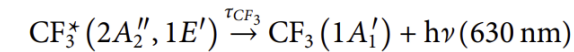
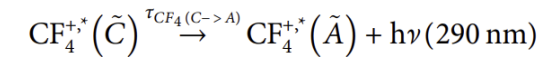
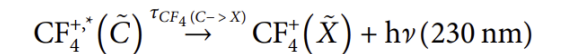
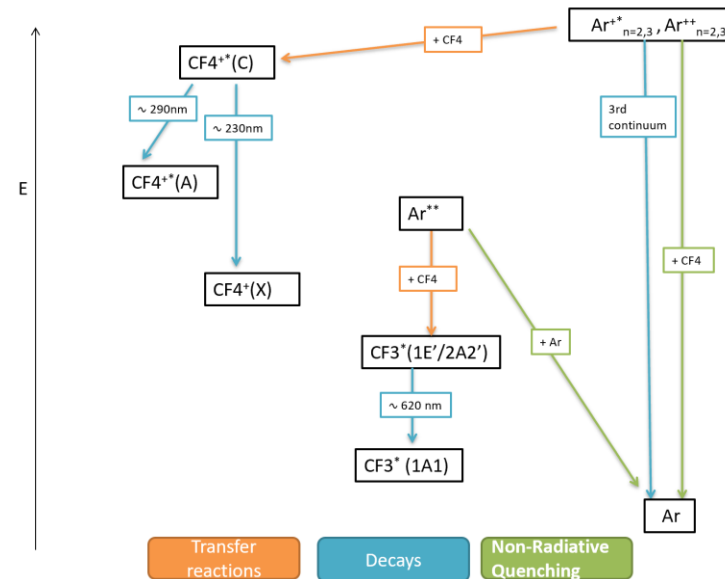
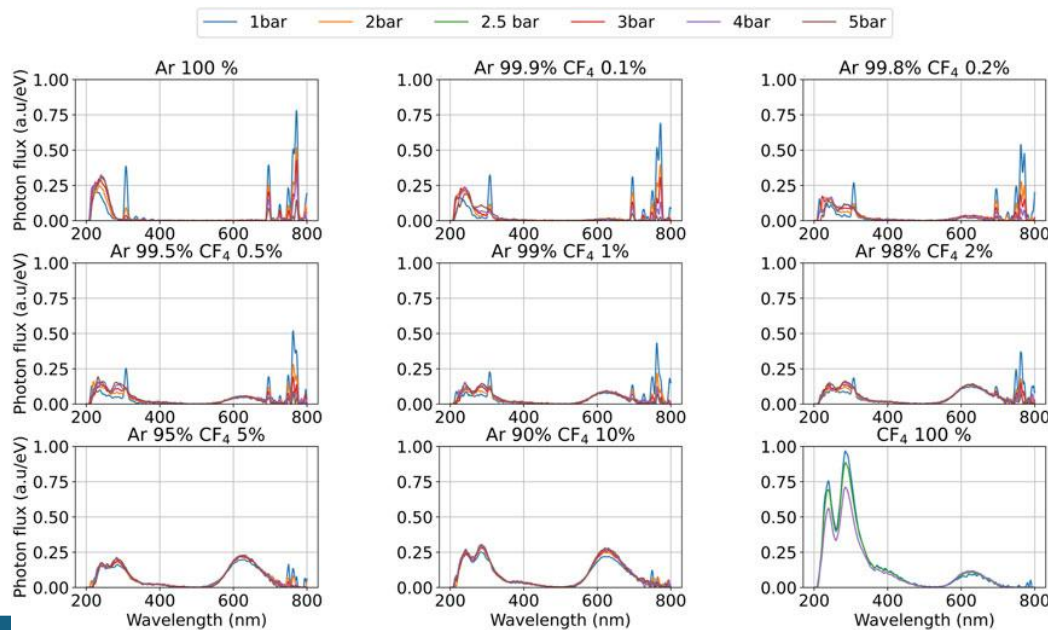
GHG	Lifetime (years)	GWP
CH ₄	12	18
N ₂ O	114	298
HFC-125	29	4,713
HFC-134a	14	1,966
HFC-152a	1.4	191
HFC-143a	52	7,829
CF ₄	50,000	7,597
C ₂ F ₆	10,000	17,035
SF ₆	3,200	31,298

Primary scintillation: previous work

- Measurements on Ar/CF₄ for different concentrations and pressures
- Scintillation model for Ar/CF₄
- Good understanding of CF₄ wavelength-shifting mechanism

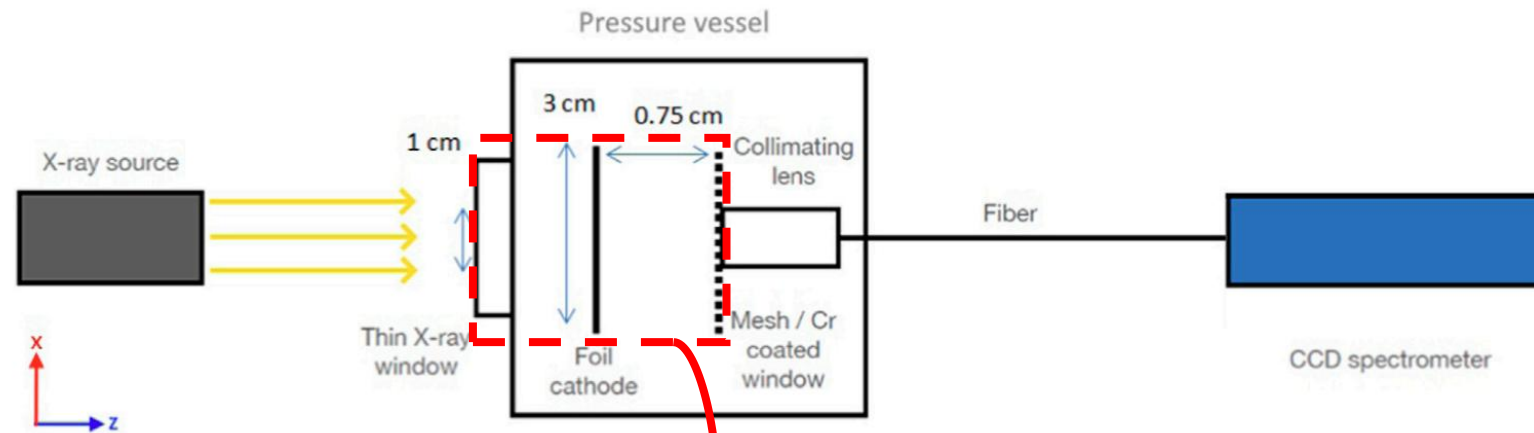


Good agreement with spectra

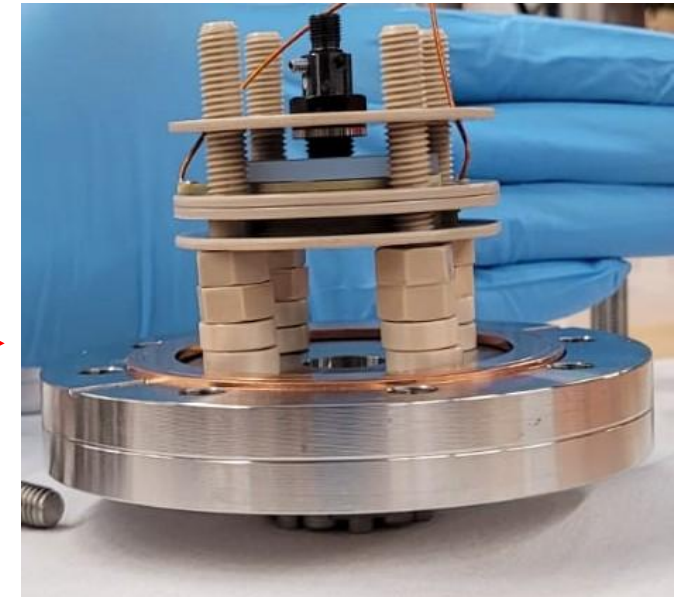


Amedo, P., et al. "Observation of strong wavelength-shifting in the argon-tetrafluoromethane system." *Frontiers in Detector Science and Technology* 1 (2023): 1282854.

Scintillation setup

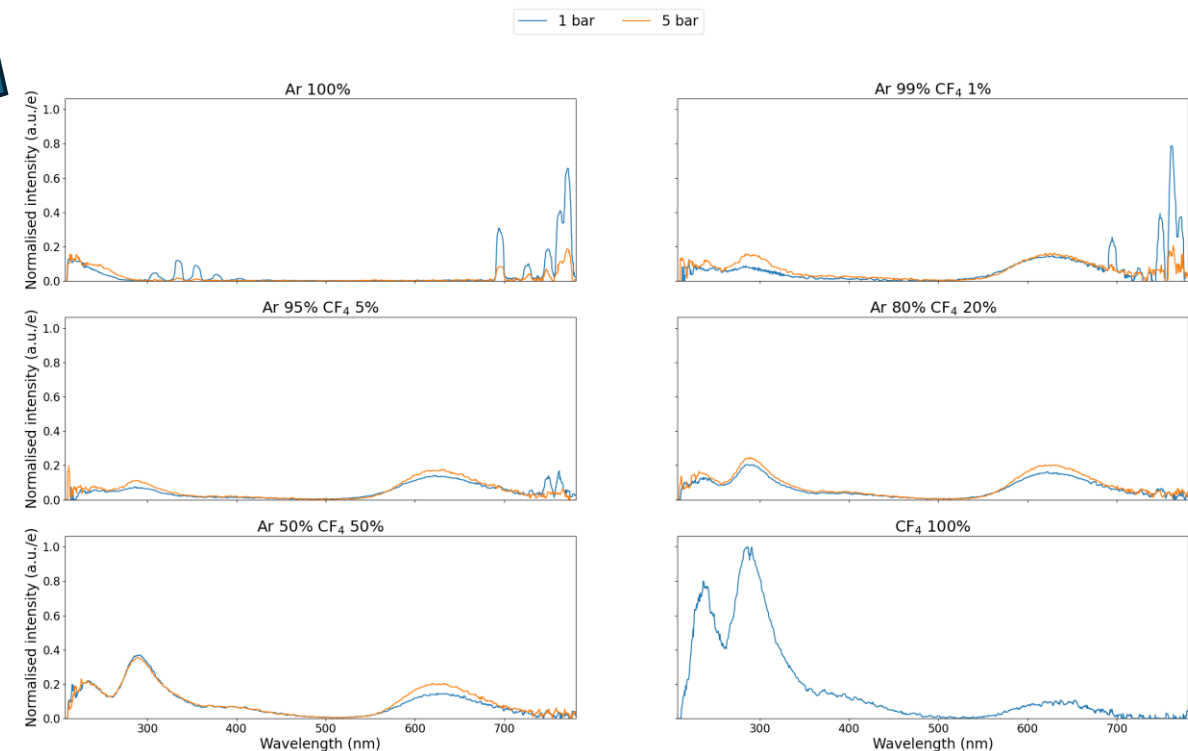
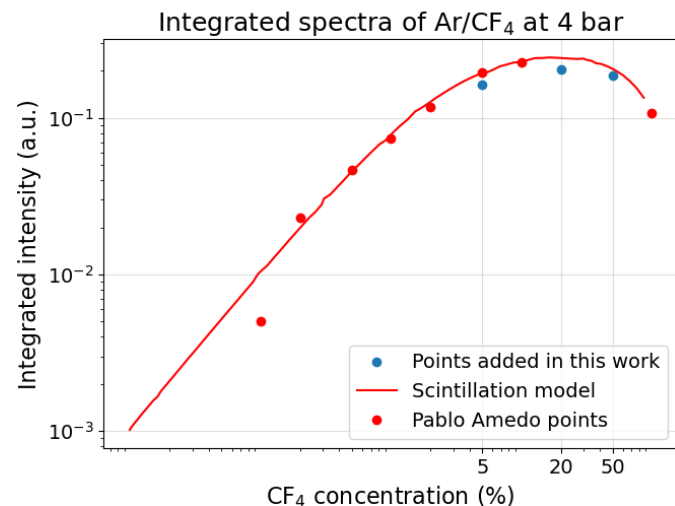


- PEEK structures → High purity system
 - Aluminum cathode
 - Cr anode over crystal window
- Chamber bake-out



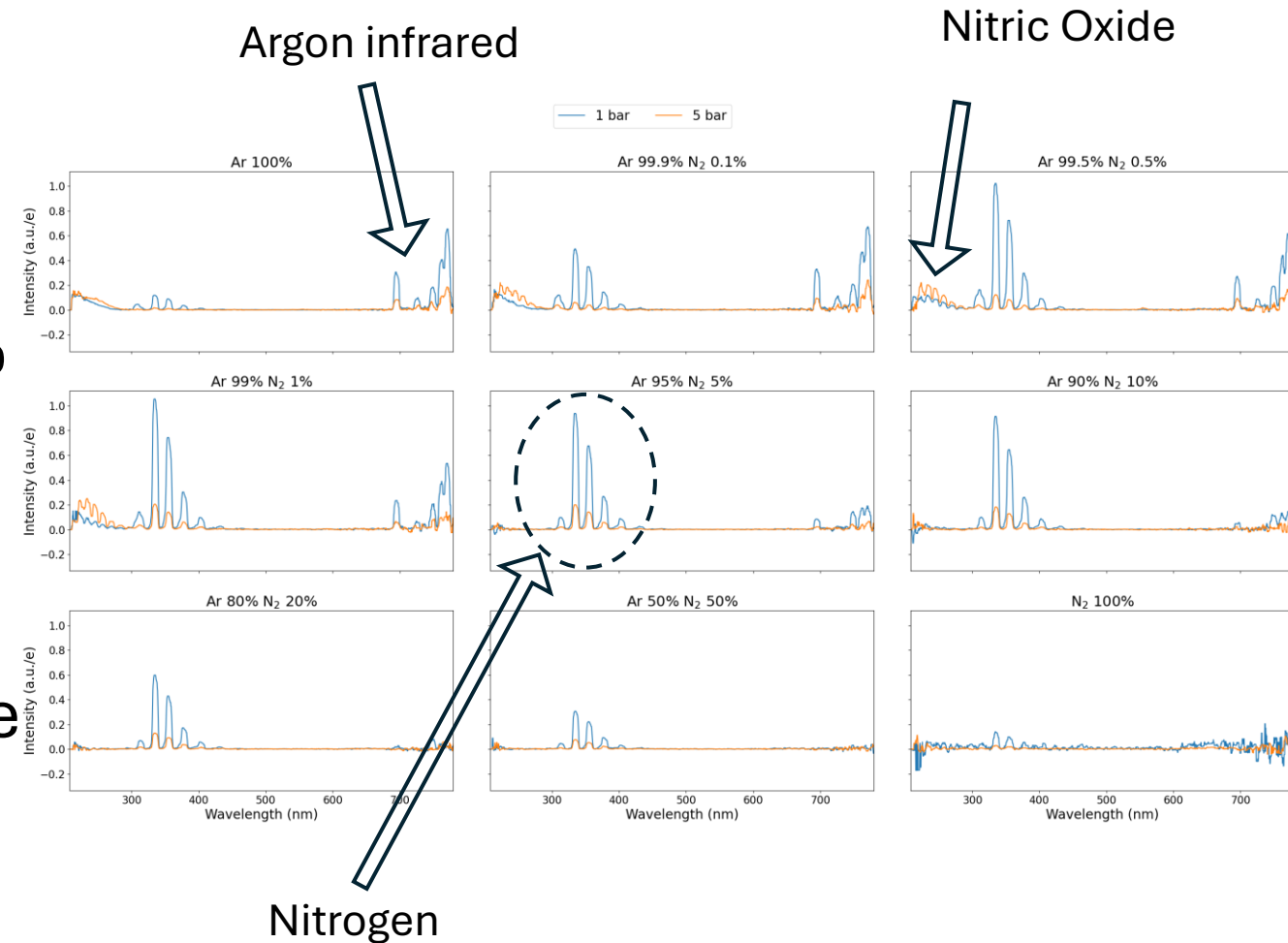
Recommissioning of the system (Ar/CF₄)

- Absence of an absolute calibration →
- Extension of the measurements to concentrations of 20% and 50% of CF₄
- Checkup: model prediction for new points (yield)
- Rescaling of new measurements to old measurements standard
- Normalization of all spectra to 290 nm of pure CF₄ at 1 bar



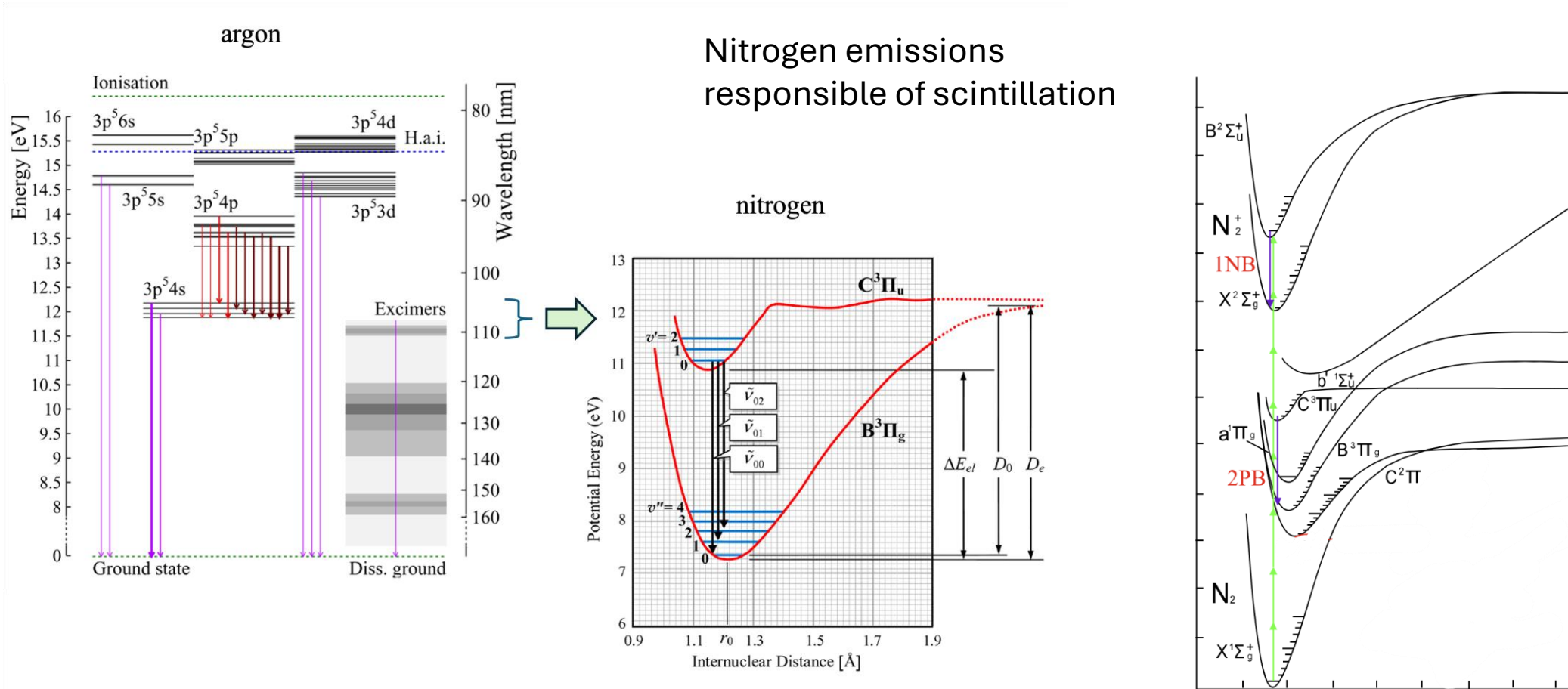
Ar/N₂ primary scintillation

- Normalized to 1 bar pure CF₄ 290nm peak
- Intensity divided by collected primary electron
- Scintillation plateau between 0.5% and 10% of N₂
- Quenching of Argon infrared peaks with increasing concentrations
- Reduction with increasing pressure (self-quenching?)



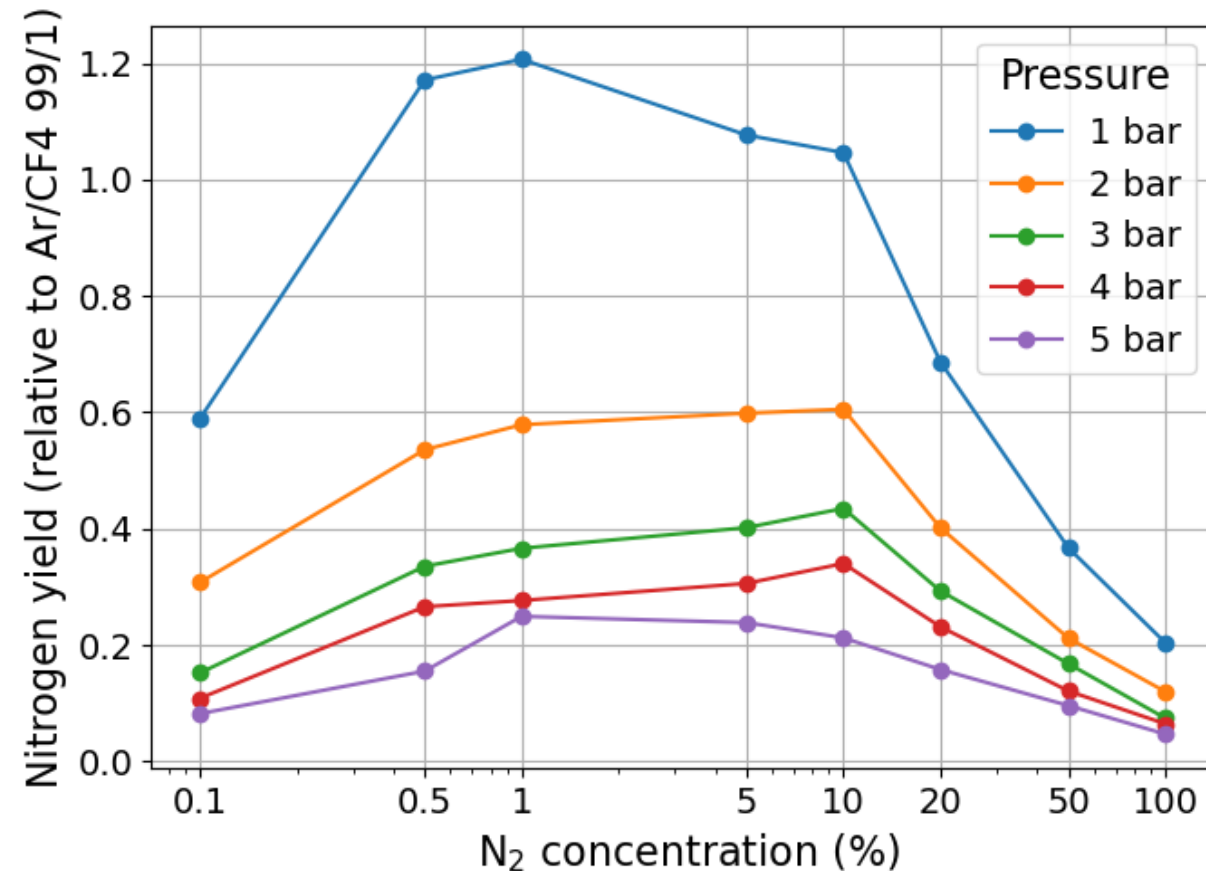
N₂ wavelength-shifting

- Close energy levels between argon and nitrogen  Energy transfer



Comparison between Ar/N₂ and Ar/CF₄ yields

- Comparison with Ar/CF₄ 99/1 at 5 bar visible emission (of interest for DUNE's NDGAr. See Pablo Amedo's talk 6th October)
- Same yield for 1 bar. Degradation with pressure.
- Large yields for the plateau



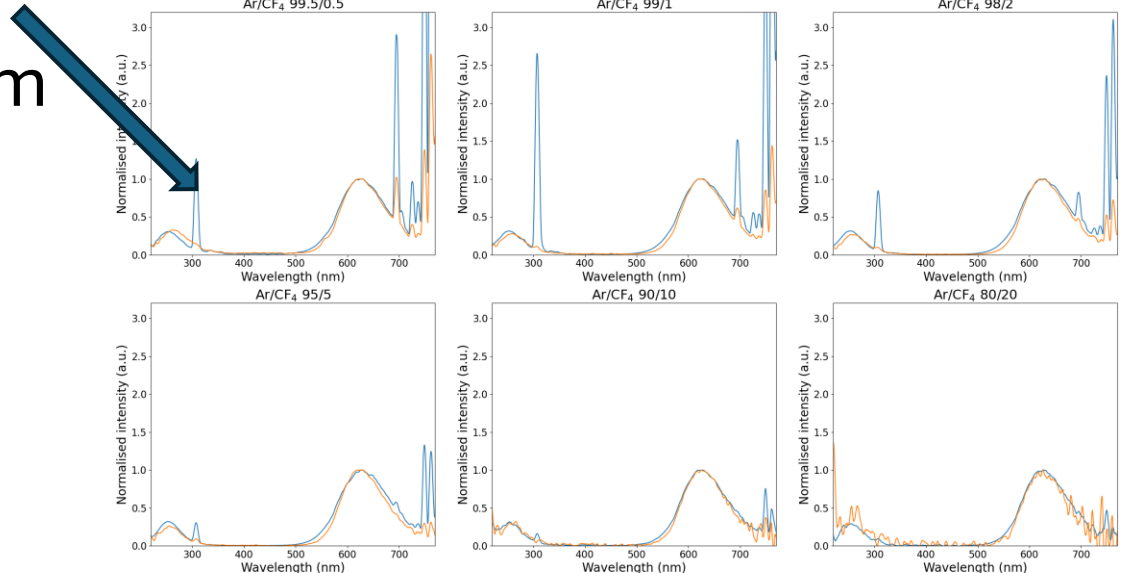
Secondary scintillation: previous work

- Important for optical tracking
- Secondary scintillation measurements for different pressures, electric fields and concentrations of CF_4
- Observation of change in scintillation spectra relative to primary (UV region)



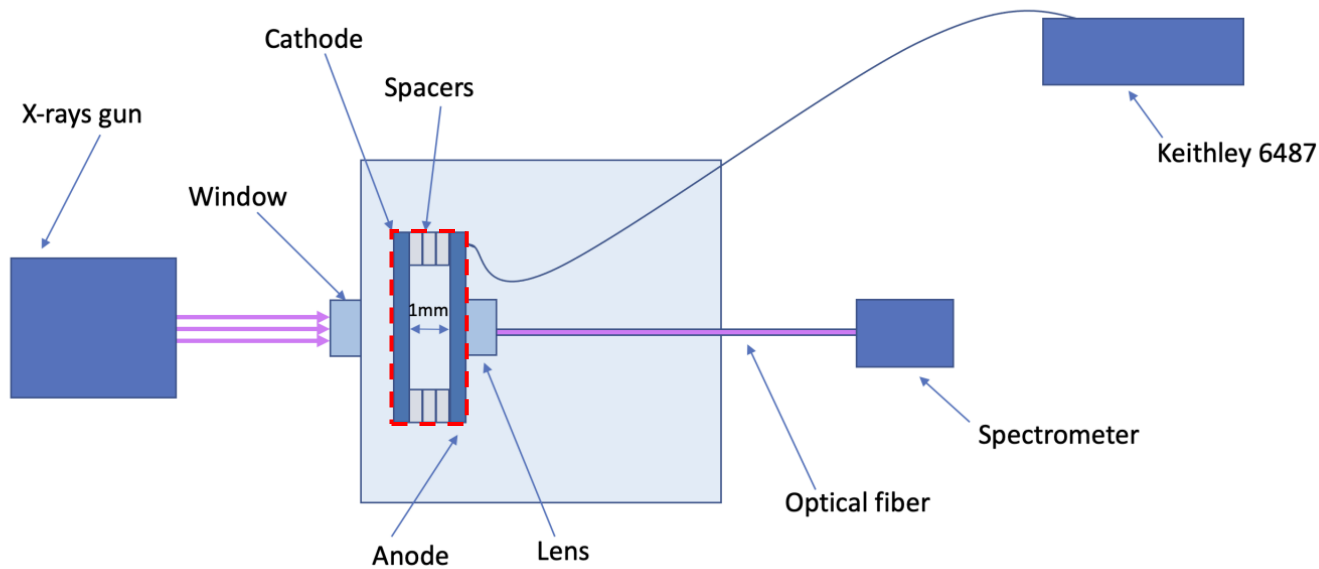
Water contamination
(OH peak)

- Shape of the scintillation spectrum independent of pressure

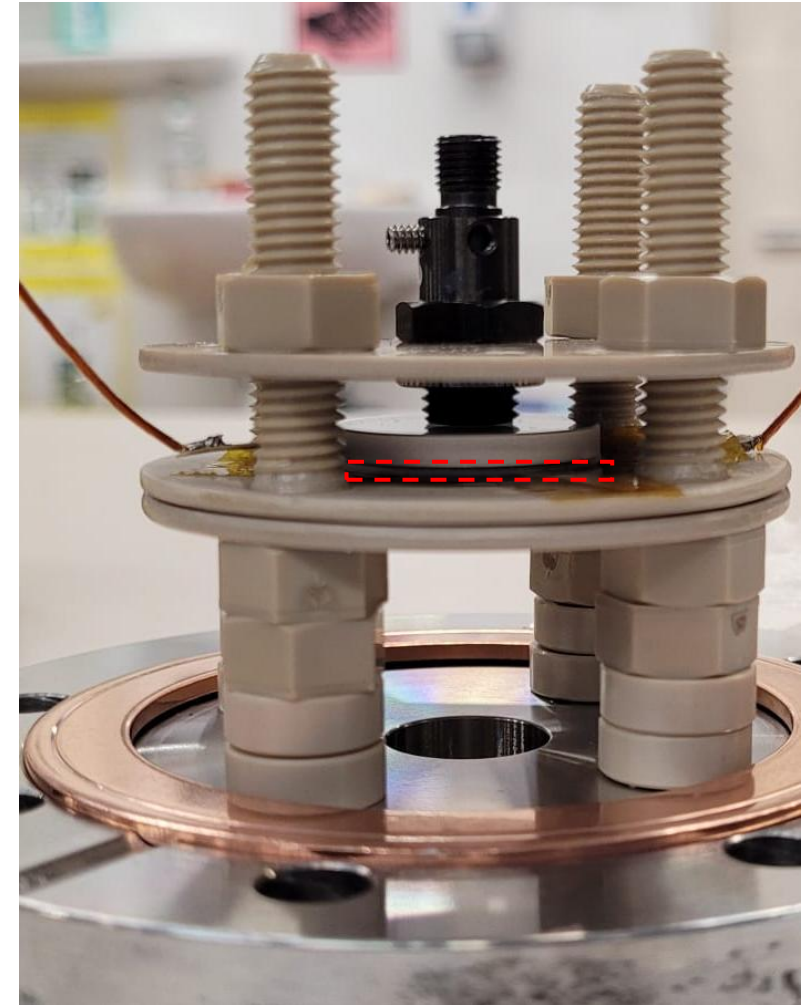


Sara Leardini's thesis

Scintillation setup (amplification)



- Smaller gap  Allows for amplification
- Parallel plate setup
- Gap size: 1mm



Recommissioning of the S2 setup

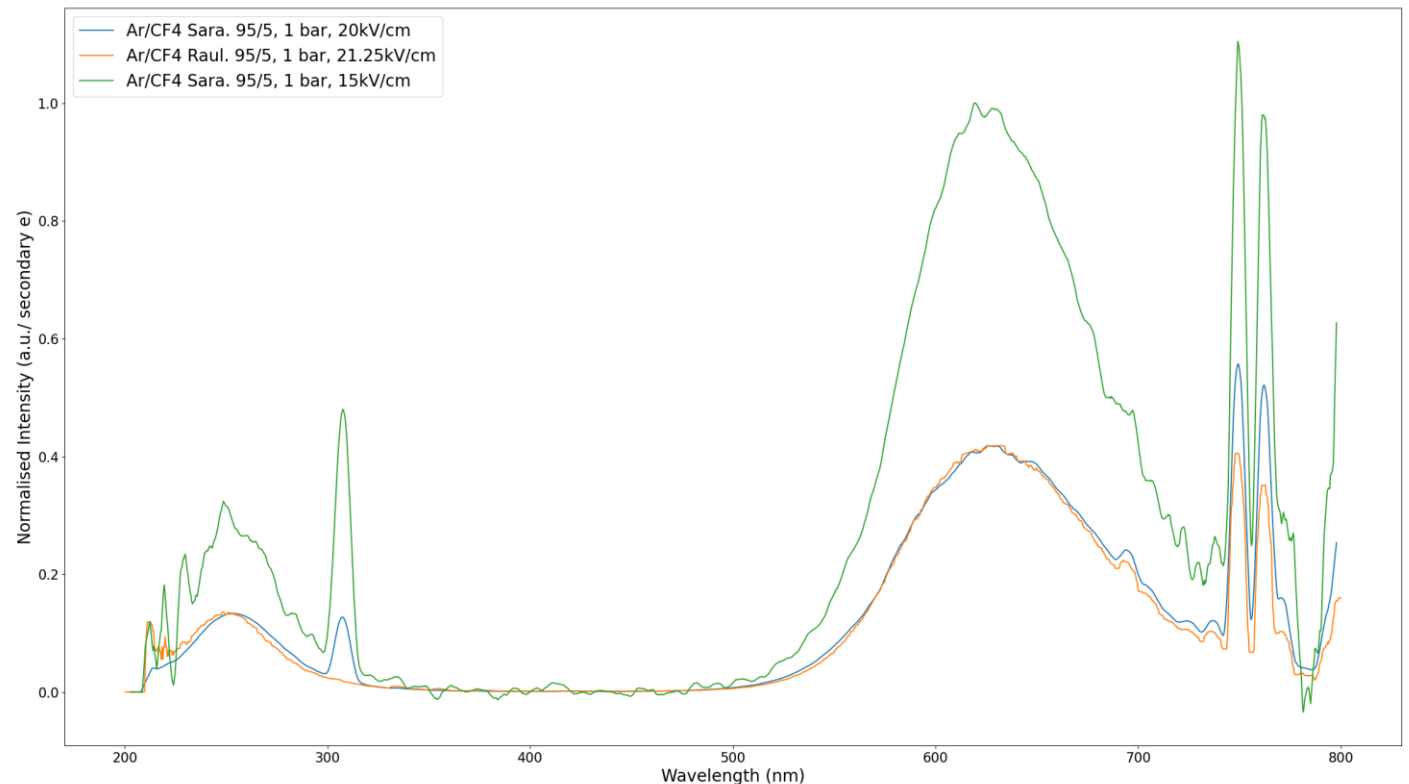
- Rescaling of spectra to match calibrations between similar conditions (Ar/CF₄ 95/5 at 1 bar in similar electric fields)
- Good agreement between spectra



Comparability between
calibration and old and new
setup conditions

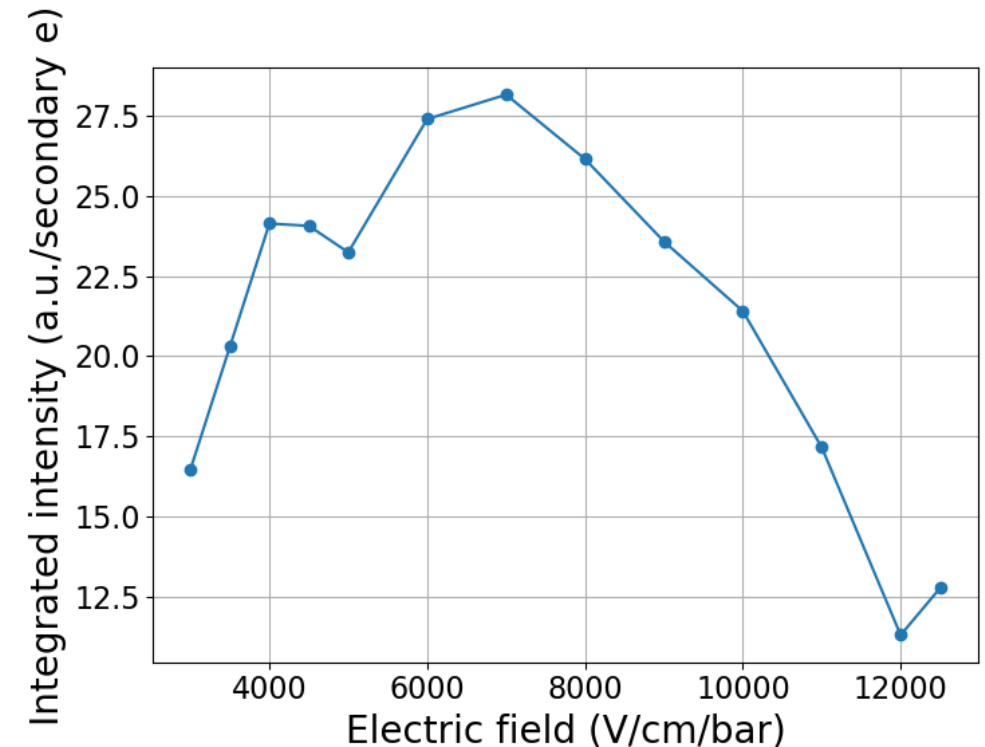
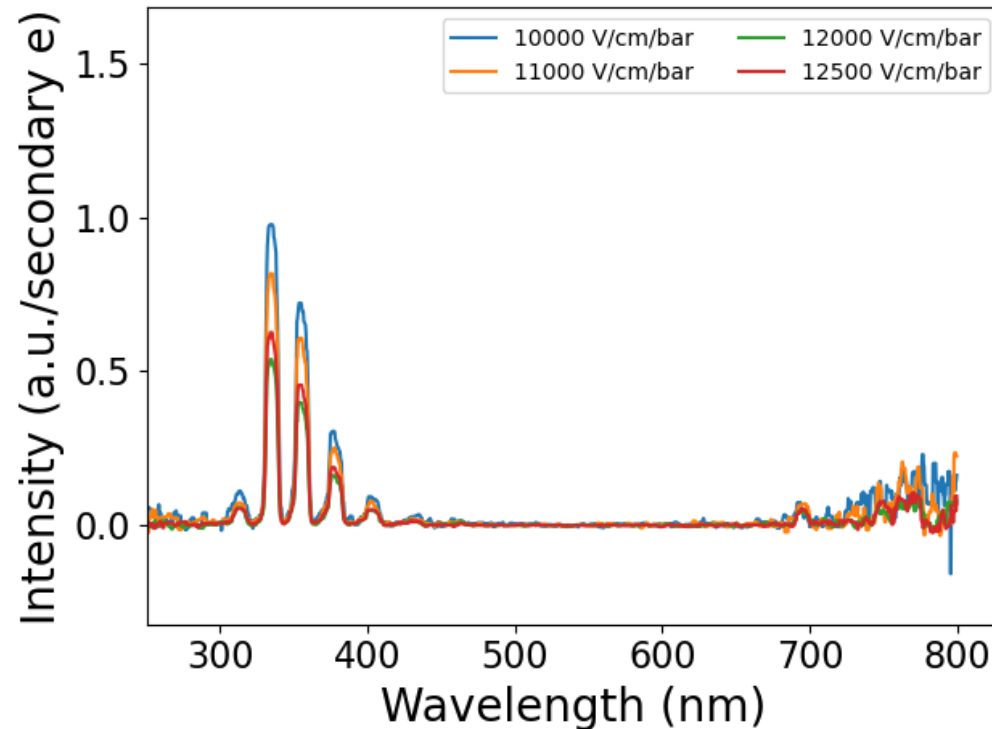


We can compare new
nitrogen measurements
with old CF₄



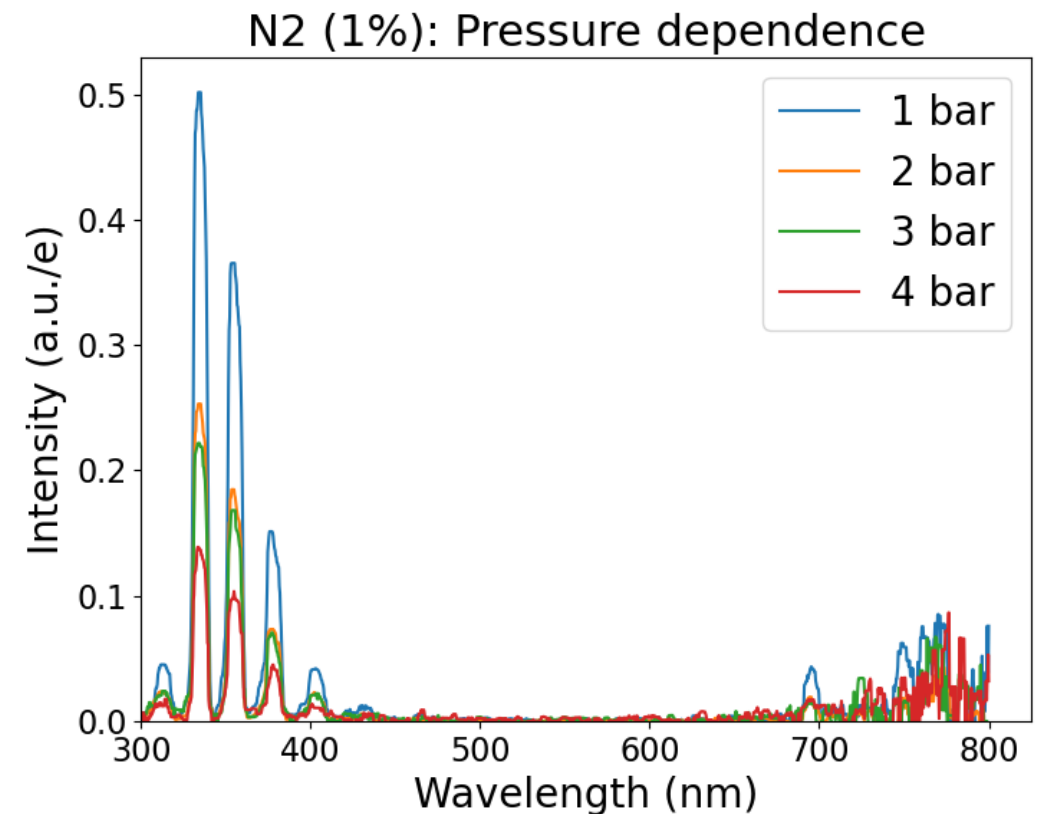
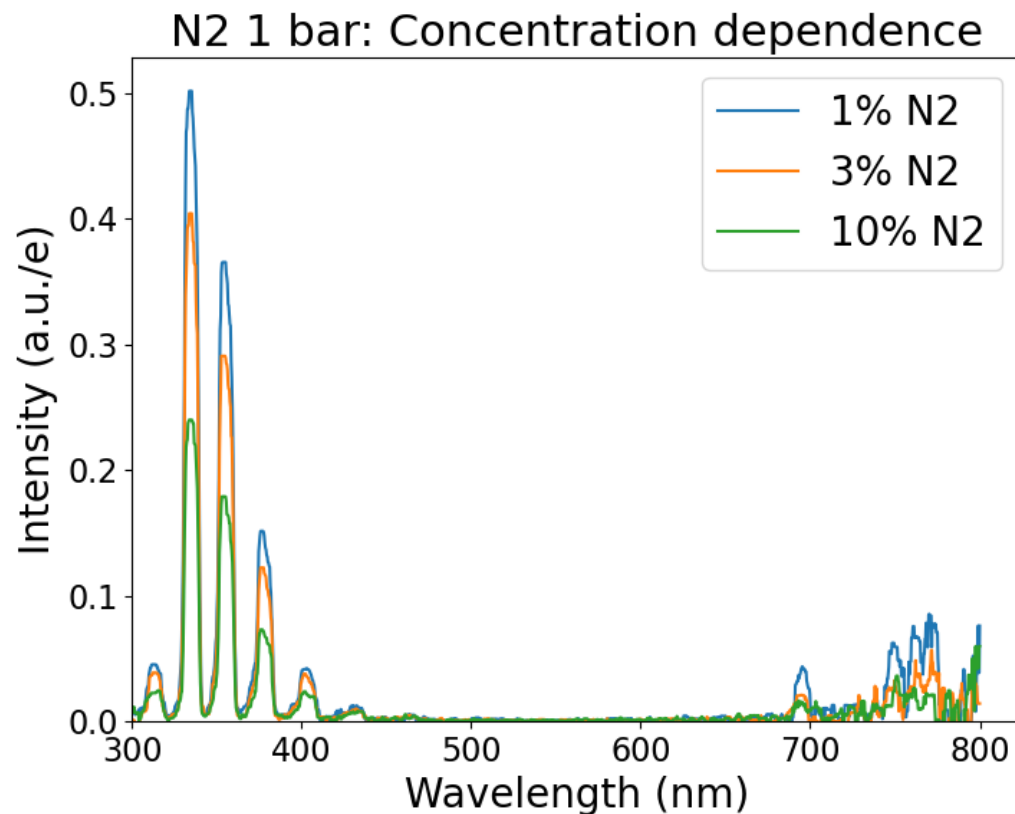
Electric field scan on Ar/N₂ 99/1

- Measurements at 1 bar
- Scintillation strength (photons per secondary electron) pretty much flat for all electric fields (Similar to Ar/CF₄)



Pressure and concentration scan for Ar/N₂ 99/1

- 1/P dependence (compatible with self-quenching)



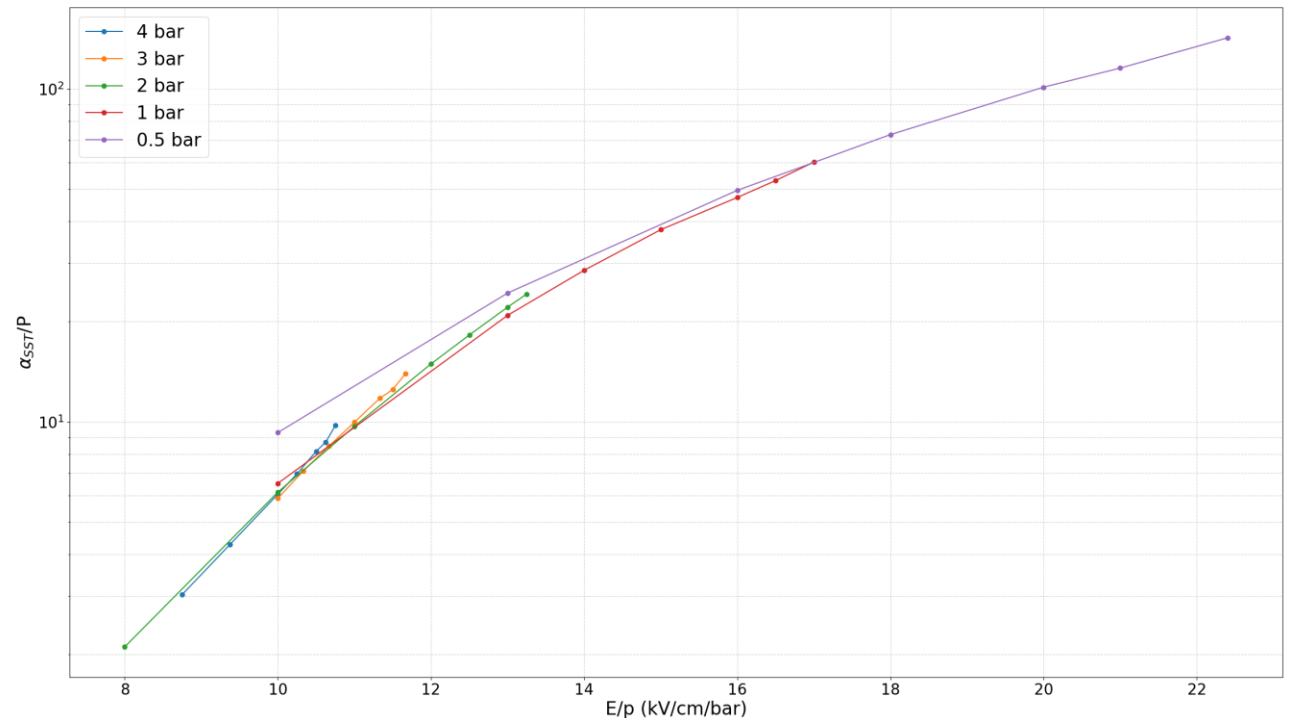
Charge gain vs pressure

- Townsend coefficient:

- $I_{anode} = I_0 \frac{1}{d} \int_0^d e^{\alpha x} dx$

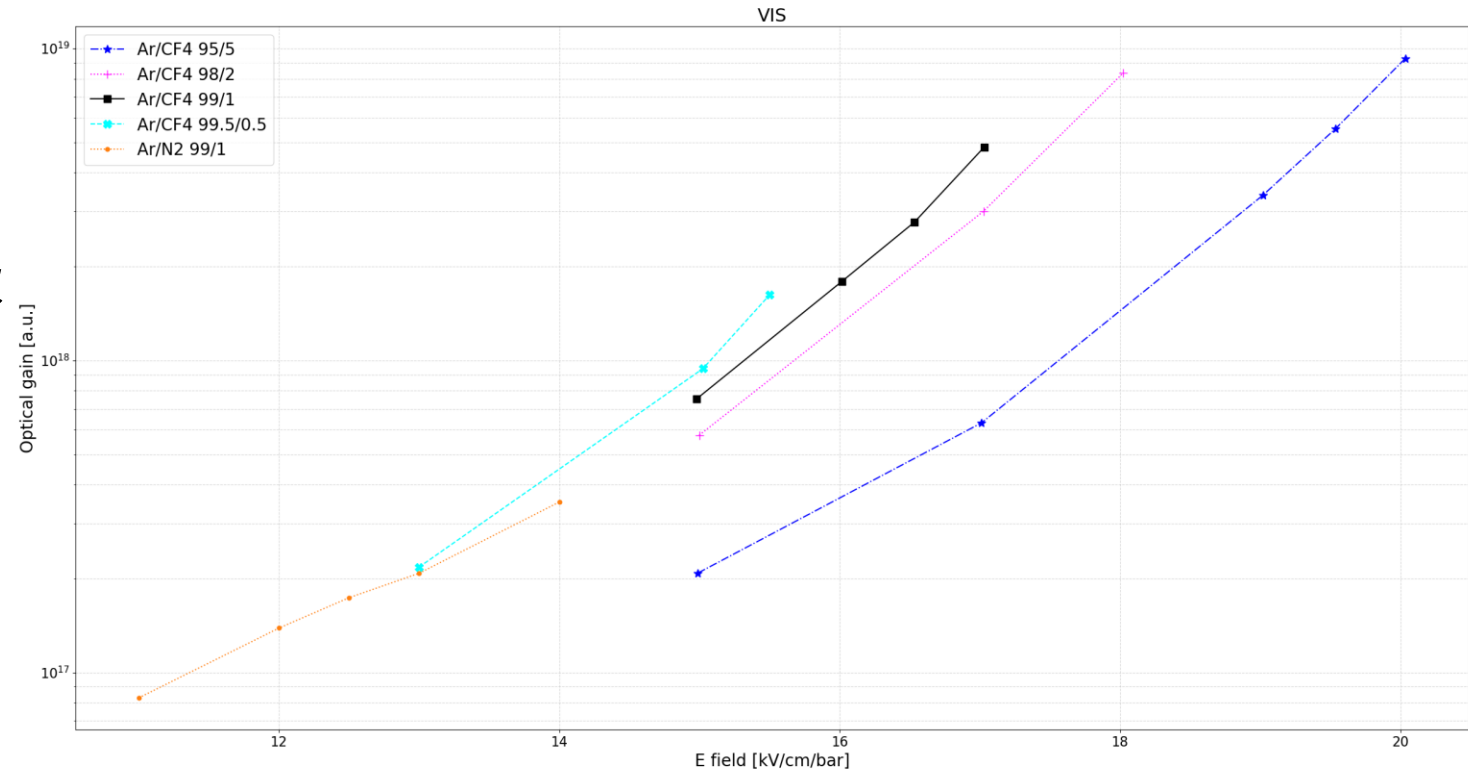
- We recover the expected scaling law for α (α/P over E/P)

$$\frac{\alpha}{P} \equiv f\left(\frac{E}{P}\right)$$



Optical gain comparison

- Optical Gain = $\frac{\int n_{ph}(\lambda) d\lambda}{I - I_0} e^{\alpha d}$
- Lower maximum gain than Ar/CF₄
- ~10 times less scintillation



Preliminary!!!

Summary

- Primary scintillation measurements under X-rays for Ar/N₂:
 - Ar/N₂ scintillation comparable to Ar/CF₄ (99/1) at 1 bar. Decreasing at high pressure (compatible with self-quenching)
 - Optimal region for wavelength-shifting (0.5-10%)
 - Scintillation increase with respect to pure nitrogen around a factor of 5
- Secondary scintillation measurements for Ar/N₂:
 - Scintillation strength (photons per secondary electron) highly independent of field  similar to Ar/CF₄
 - Optical gain about 10 times smaller than Ar/CF₄ at 1% concentration
 - Maximum voltage limited by discharges in the spacers
 - We plan to eliminate spacers and study more systematically the dependence with N₂ concentration as well as the maximum optical gain with GEMs at high pressure

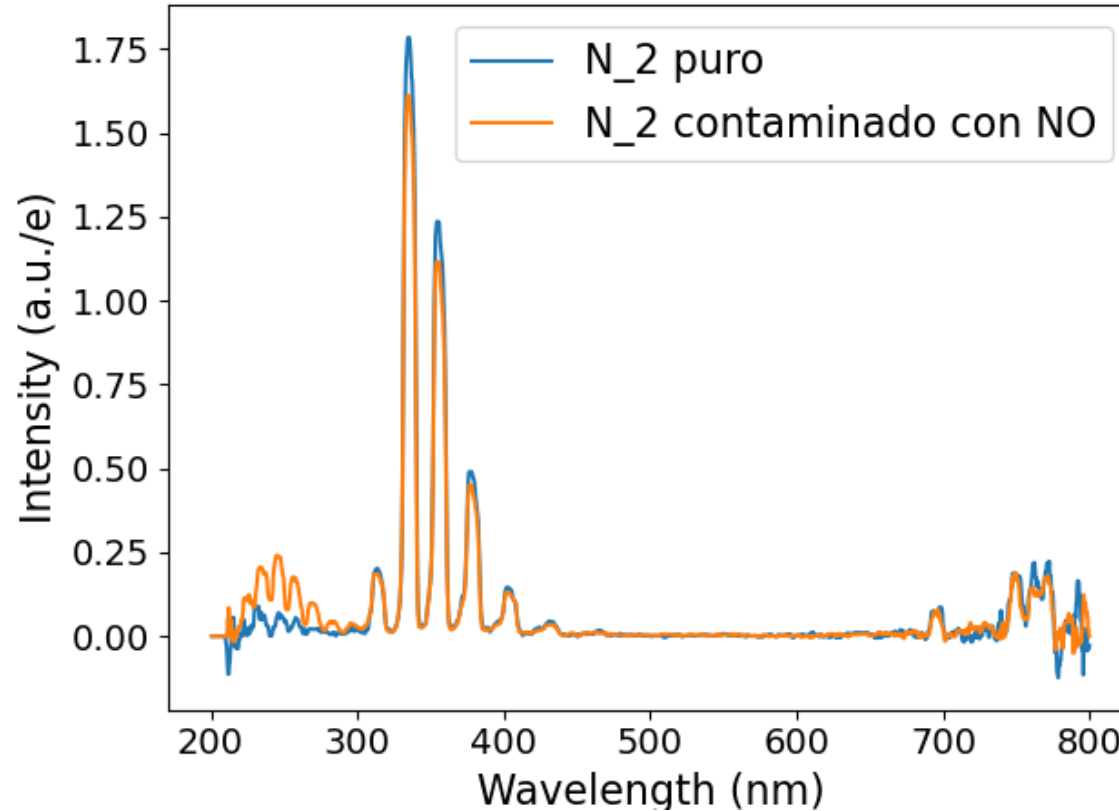
Summary



- Primary scintillation measurements under X-rays for Ar/N₂:
 - Ar/N₂ scintillation comparable to Ar/CF₄ (99/1) at 1 bar. Decreasing at high pressure (compatible with self-quenching)
 - Optimal region for wavelength-shifting (0.5-10%)
 - Scintillation increase with respect to pure nitrogen around a factor of 5
- Secondary scintillation measurements for Ar/N₂:
 - Scintillation strength (photons per secondary electron) highly independent of field  similar to Ar/CF₄
 - Optical gain about 10 times smaller than Ar/CF₄ at 1% concentration
 - Maximum voltage limited by discharges in the spacers
 - We plan to eliminate spacers and study more systematically the dependence with N₂ concentration as well as the maximum optical gain with GEMs at high pressure

Backup

Independence from oxygen contamination



Setup instability

Ar/N₂ 99/1 at 1bar

